## **Supplementary Materials**

The Degradation and Recovery behaviors of Mix-cations Perovskite Solar Cells in Carbon Dioxide and Moisture Environment

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## **Supplementary Figures**



**Figure S1.** On-off ratio from perovskites devices' *J-V* characteristic curves of dark and light.



**Figure S2.** Hysteresis loop scan of dark IV curve for Au device collected under ambient environment.



Figure S3. Time evolution of (a) the normalized  $V_{OC}$  and (b)  $J_{SC}$  under dry nitrogen environment.



**Figure S4.** Time evolution of (a) the normalized  $V_{OC}$  and (b)  $J_{SC}$  for repeating CO<sub>2</sub> with RH=0%.



**Figure S5.** Time evolution of (a) the normalized  $V_{OC}$  and (b)  $J_{SC}$  under ambient environment (air, R.H. = 20 %).



**Figure S6.** Hysteresis loop scan with repeating light *J-V* curves for CO<sub>2</sub> with RH=0% at fresh, degraded and recovered status.



**Figure S7.** Hysteresis loop scan with repeating light J-V curves for CO<sub>2</sub> with RH=60% at various exposure time.



**Figure S8.** Hysteresis loop scan with repeating light J-V curves for CO<sub>2</sub> with RH=90% at various exposure time.



**Figure S9.** SEM surface views for perovskite thin film (a) before and (b) after the exposure in  $CO_2$  with R.H.=90% environment for 2 hours under illumination. XRD patterns for the perovskites device before and after testing under  $CO_2$  with R.H.=90% environment.



**Figure S10.** UV-Vis absorption spectra for the perovskites device before and after testing under  $CO_2$  with R.H. = 90 % environment.



Figure S11 Detailed analysis for the device degradation behavior in dry N<sub>2</sub> versus dry CO<sub>2</sub>



Fig. S12 Time evolution of the device's PCE for longer time (2-hr) of exposure to R.H. = 90 % in  $CO_2$  gas.



Fig. S12 device made with perovskite layer without ionic liquid additive. The degradation tests are performed under illumination and in dark for recovery observations. (a) &(b) are normalized  $V_{OC}$  and  $J_{SC}$  curves in dry CO<sub>2</sub>, (c) &(d) are the same figure of merits in humid CO<sub>2</sub>.



Fig. S13 The device's degradation behavior under  $N_2$  with R.H. = 90 % The time evolution of (a) normalized  $V_{OC}$  and (b) normalized  $J_{SC}$  when exposed under constant illumination. (c) normalized JV curves to compare the JV behavior before and after degradation.